Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	der
10/770,435	SHI ET AL.	
Examiner	Art Unit	
An T Luu	2816	

SEARCHED					
Class	Subclass	Date	Examiner		
327	156 157 159				
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331	17		,		
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327	540				
323	313				
	316	3/05	All		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST	3/05	ALL	
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